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Radiative recombination in Cu$_2$ZnSnSe$_4$ thin films with Cu deficiency and Zn excess

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Abstract

Thin films of Cu$_2$ZnSnSe$_4$ (CZTSe) with copper deficiency and zinc excess were fabricated at Northumbria University by the selenisation of metallic precursors deposited on Mo/glass and bare glass substrates. Absorption and photoluminescence (PL) measurements were used to examine the film on glass whereas films on Mo/glass were used to produce a solar cell with efficiency of 8.1%. Detailed temperature and excitation intensity analysis of PL spectra allows identification of the main recombination mechanisms as band-to-tail and band-to-band transitions. The latter transition was observed in the spectra from 6 to 300 K.

Keywords: Cu$_2$ZnSnSe$_4$, solar cells, photoluminescence.

1. Introduction

The semiconductor Cu$_2$ZnSn(S,Se)$_4$ is one of the most promising materials for use as the absorber layer in sustainable thin-film solar cells. It contains cheap and earth abundant elements. Its reported conversion efficiency record exceeds 12% [1] whereas in the pure selenide version Cu$_2$ZnSnSe$_4$ (CZTSe) it exceeds 11% [2]. The lattice structure as well as the electronic properties of Cu$_2$ZnSn(S,Se)$_4$ are similar to those in Cu(In,Ga)Se$_2$ (CIGS) [3,4,5]. Such a similarity allows technological solutions, originally developed for CIGS-based solar cells, to be used in CZTSe-based technologies [4].

Intrinsic structural defects, introduced by deviations from the ideal stoichiometry, as with CIGS, are held responsible for the $p$-type doping of CZTSe [4,5]. Although such defects influence charge carrier generation and recombination processes in CZTSe solar cells very little experimental evidence can be found in the literature on the nature of the defects [6-9]. Understanding the electronic properties in this material is mostly based on theoretical studies using density functional theory [5,10] however it is essential to experimentally validate the theoretical findings [4].

Although reported elemental compositions of CZTSe absorber layers, used for solar cells, are rather scattered those in high-performance devices are concentrated at significant deviations from the ideal stoichiometry: copper deficiencies ([Cu]/[Sn+Zn] ratios) as low as 0.8 and zinc excesses ([Zn]/[Sn] ratios) as high as 1.2 [5,11]. At such deviations we can expect the presence of high populations of defects which is hardly compatible with the electrical properties required for high efficiency devices. In CIGSe similar paradox is resolved by efficient mechanisms of electrical passivation of the antisite defect (indium or gallium on copper site, In$_{Cu}$ or Ga$_{Cu}$), which is the main compensating donor in Cu deficient material. This occurs by formation of the neutral defect complexes $2V_{Cu}^+$ In$_{Cu}$ and $2V_{Cu}^+$ Ga$_{Cu}$, and provides an opportunity to dope CIGS with a shallow acceptor (copper vacancy V$_{Cu}$) by shifting the elemental composition towards In or Ga excess [12].

Theoretical studies of the possible defect types and their formation energies in CZTSe suggest the presence of similar mechanisms of charge passivation by the formation of donor-acceptor complexes [5]. For copper deficient and zinc excess compositions the defect complexes $V_{Cu}^+$Zn$_{Cu}$ are expected to be formed.

One of the most efficient techniques to study defects in semiconductors is photoluminescence (PL) [13]. The quality and quantity of the information, gained in such studies, critically depends on the structural quality of the studied material [14]. Therefore studies on the highest quality CZTSe provide more information on defects and the electronic properties [6,15]. From the technological point of view it is important to examine PL emission in CZTSe with deviations from stoichiometry required for doping absorbers in efficient solar cells. Low temperature PL spectra of such films reveal a single broad and asymmetrical band attributed to band tail related [7,9,16] and quasi-donor-acceptor pairs [17] recombination. This band usually rapidly quenches with increasing temperature [7] but can be observed up to 180 K in films used as absorber layer in solar cells with high conversion efficiency [9]. On the other hand room temperature PL spectra in such films show an emission band at a spectral energy close to the band gap and assigned to a band-to-band transition [18,19].
However no reports on such a band in CZTSe in low temperature PL spectra or its evolution with temperature can be found in the literature.

In this report we present an optical spectroscopy study of thin films of CZTSe with copper deficiency and zinc excess deposited on glass substrate. Similar CZTSe films, simultaneously deposited on Mo/glass substrates, were used as absorber layers in solar cells with a conversion efficiency of 8.1%. Analysis of the excitation intensity dependence and evolution of the PL spectra with temperature (from 6 to 300 K) and comparison of their spectral energies with the band gap, determined from absorption spectra, helps to identify the recombination mechanism of the dominant emission bands as band-to-tail and band-to-band transitions.

2. Experimental details

Thin films of Cu$_2$ZnSnSe$_4$ were synthesised at Northumbria University by the selenisation of metallic precursor layers deposited using magnetron sputtering of high-purity elemental targets. These precursors were simultaneously deposited on Mo-coated and bare soda-lime glass substrates at room temperature and then selenised in selenium vapour following a two-step rapid thermal process at 300 °C and 500 °C, for 5 and 15 minutes, respectively. Se pellets were used as the chalcogen source. More information on the synthesis of compound films by selenisation of magnetron deposited multilayer metallic precursors can be found in [6,15].

The CZTSe films on Mo/glass substrates were etched with 10 wt% KCN solution for 30 seconds. CdS buffer layers were then deposited on them, using a standard chemical bath process. Solar cells were fabricated by DC-magnetron deposition of ZnO/ZnO:Al transparent front contacts. The principal device parameters for mechanically scribed 3×3 mm$^2$ solar cells were examined under simulated AM1.5 solar illumination (100 mW/cm$^2$, 25ºC): $V_{oc} = 434$ mV, $J_{sc} = 31.2$ mA/cm$^2$, $FF = 59.6\%$ yielding a conversion efficiency of $\eta = 8.1\%$.

The films deposited on glass substrates were characterised using a number of techniques. Their morphology was analysed using a low-vacuum scanning electron microscopy (SEM) and wavelength dispersive X-ray (WDX) microanalysis at 5 and 10 keV electron beam energy, respectively. The structural properties and the presence of secondary phases were examined by X-Ray diffraction (XRD) measurements carried out using a Siemens D-5000 diffractometer in the Bragg–Brentano geometry and a Cu K-α radiation source ($\lambda = 0.15406$ nm).

The temperature and excitation intensity dependent PL measurements were carried out using a 1 m focal length monochromator, the unfocused 514 nm line (0.7 mm diameter) of a 300 mW Ar$^+$ excitation laser and a closed-cycle helium cryostat. The laser power density on the film was varied from 2.7 mW/cm$^2$ to 0.13 W/cm$^2$. The PL signal was detected by an InGaAs photomultiplier tube in the spectral range from 0.9 to 1.7 µm. More experimental details of the set up can be found in [6,15]. Optical transmission and reflection measurements were performed at room temperature in the spectral range from 600 – 1800 nm and used to determine the band gap at room temperature.

3. Results and discussion

The film average thickness of 1.6 µm can be seen in a cross section view of the film shown in figure 1.

![Figure 1](image1.png)

**Figure 1.** Cross-section view SEM micrograph of the CZTSe film on glass substrate.

The elemental composition (Cu 21.1, Zn 15.1, Sn 13.5 and Se 50.3 at.%) demonstrates a copper deficiency over the Sn and Zn sum [Cu]/[Zn+Sn] = 0.74, excess of zinc over Sn [Zn]/[Sn]=1.12 and nearly stoichiometric ratio of Se to the sum of metals [Se]/[Cu+Zn+Sn] = 1.01.

The XRD pattern, shown in figure 2, reveals distinct lines of a tetragonal CZTSe lattice structure.

![Figure 2](image2.png)

**Figure 2.** XRD pattern of the film on glass substrate.

No significant lines of secondary phases can be seen in the patterns but we cannot rule out the presence of ZnSe and Cu$_2$SnSe$_3$ because their crystalline structures are quite similar to that of CZTSe [4,16].

Room temperature optical absorption $a(h\nu)$ is calculated using transmittance and reflectance spectra shown in figure 3(a) [20]. For an allowed direct transition the spectral dependence of the absorption coefficient can be calculated as $a=A(h\nu - E_g)^{1/2}/h\nu$, where $A$ is a constant, $E_g$ is the optical band gap and $h\nu$...
is the photon energy [21]. Figure 3(b) shows the room temperature dependence of \((ahv)^2\) on \(hv\).

A band gap of \(E_g = (1.01\pm0.02)\) eV is determined by extrapolating the linear part of \((ahv)^2\) to the \(hv\) axis. This value is in a good agreement with \(E_g = 1.01\) eV obtained for high structural quality CZTSe with excitonic features in the PL spectra [6] and suggests a high degree of ordering of Cu and Zn on the lattice [22].

PL spectra measured at different excitation laser power densities at 6 K are shown in figure 4. Features due to water absorption can be seen in the region of 0.9 eV. The spectra are dominated by a broad and asymmetric band BT, labelled for band tail related recombination, with a maximum at 0.94 eV. The high energy side of the BT peak is steeper than the low energy side of the BT peak is steeper than the low energy energy one. The BT band shifts with increasing energy of order of Cu and Zn on the lattice [22].

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An evolution of normalised PL spectra measured at temperatures from 6 to 300 K is shown in Fig. 5 on a linear scale to identify the types of radiative recombination mechanisms. The dominant BT band quenches at temperatures above 100 K, gradually shifting towards lower energies, which indicates that it is associated with the valence band tail [23,24].

The BB band is visible from 6 K. It becomes clearly resolved at 74 K and its intensity remains significant up to room temperature. With temperature increase the BB band shifts towards lower energies as seen in figure 5. The BT and BB bands in the PL spectra have also been reported for Cu2ZnSnS4 [27,28].

A semiconductor is highly doped if the average distance between defects is smaller than their Bohr radii, causing the wave-functions of these defects to overlap [25]. Theoretical estimates for CZTSe give the density of state (DOS) hole mass \(m^* = 0.21m_0\), where \(m_0\) is the free electron mass, which is significantly heavier than that of the electron \(m_e = 0.08m_0\) [10]. Thus the condition of high doping is easier to satisfy for donors whereas heavy holes can be treated as classical particles. In ternary and quaternary chalcopyrite single crystals [24,29] and thin films [30,31], as well as in the
kesterites [7], the condition of high doping is assumed to be satisfied for electrons and not satisfied for holes. At low temperatures holes are localised at deep hydrogenic states of the valence band tail acting like acceptor levels. A PL emission band at 0.94 eV has been reported previously for CZTSe [7,9] and attributed to valence band tail related transitions. An energy diagram with band-to-tail (BT) recombination of free electrons with holes localised at deep valence band tail states, and band-to-band (BB) recombination is shown in figure 6 for a semiconductor with spatial potential fluctuations and the condition of high doping satisfied for donors.

The BT band is broad and has a characteristic asymmetrical shape. The low-energy side of the band is defined by the density of state function of the valence band tail $\rho_v(\varepsilon)$ [23,32]. A good approximation of such a density of states is $\rho_v(\varepsilon) \sim \exp(-\varepsilon/\gamma_0)$ [23], where $\gamma_0$ is the average depth of the potential energy fluctuations. The low energy side depends neither on temperature nor on excitation intensity, as shown in figure 4 and 5. The high energy side of the band has a more complex nature [23].

![Energy diagram of proposed radiative recombination mechanisms.](image)

Figure 6. Energy diagram of proposed radiative recombination mechanisms.

Once the temperature increases shallower states begin releasing the holes whereas those at deeper states stay localised causing the observed red shift of the BT recombination [23,24]. At this stage of analysis however we cannot rule out the band-to-impurity (BI) recombination, where free electrons recombine with holes localised at acceptors with ionisation energy greater than $\gamma_0$. In materials with spatial potential fluctuations BI also has the characteristic asymmetric shape and red shifts at rising temperature as well as a significant blue shift at increasing excitation intensity [23,29].

Arrhenius analysis of the temperature dependence of the integrated intensity of the BT band after subtraction of the BB and HT bands, is shown in figure 9. The best fit, shown by the line, is achieved for one recombination channel assuming a temperature dependent capture cross section for the localised holes [33]:

$$I(T)=I_0/(1+A_1T^{3/2}+A_2T^{3/2}\exp(-E_a/k_BT)).$$  

(1)

where $I_0$ is the band intensity at the lowest temperature, $A_1$ and $A_2$ are process rate parameters and $k_B$ is the Boltzmann constant. An activation energy $E_a$ of $(13 \pm 1)$ meV is determined. A valence band tail related transition can be described by effective ionisation energy of those acceptor-like states which define the radiative recombination.

In the case of band-to-tail type recombination $E_a$ is a fraction of $\gamma_0$. An average tail depth of $\gamma_0 = 37$ meV is estimated from the low energy slope of the BT band PL spectrum at 6 K [23,24]. The value of $E_a$ is smaller than $\gamma_0$ suggesting that the BT band is more likely to be a band-to-tail type recombination than BI.

The low intensity HT band can probably be related to defects of a secondary phases which can be formed at Zn excess conditions [16,34]. The HT intensity increases up to 70 K. The BT band can be assigned to a recombination of free electrons with holes localised at deep valence band tail states as shown in figure 6. At low temperatures free holes are captured at localised tail states. They have a low probability of being released and a higher probability of recombining with free electrons.
becomes significant at higher temperatures when the BT band quenches.

The temperature dependence of the BB band, shown in Fig.8, demonstrates a decrease of the spectral energy from 1.035 eV at 74 K to about 1 eV at room temperature. This closely matches the $E_g$ from the absorption experiments so we can consider the BB temperature dependence to follow that of the band gap. The observed 35 meV temperature red shift is close to that of 40 meV observed for excitonic grade CZTSe over a slightly greater temperature change from 4 to 300 K [15] but greater than the 20 meV derived from spectroscopic ellipsometry spectra of a film with lower Cu deficiency and Zn excess [35].

![Figure 7](image7.png)

**Figure 7.** Fitting of the PL spectrum at 74 K with Gaussians representing BT, BB and HT bands.

The high intensity of PL in general and the appearance of the BB transition in a material with copper deficiency and zinc excess at temperatures from 6 to 300 K suggest that despite the presence of band tails, there are low rates of non-radiative recombination and scattering on defects and that the structural quality of the thin film is relatively good.

![Figure 8](image8.png)

**Figure 8.** Temperature dependence of the BT and BB band maxima.

Theoretical studies suggest that the defect complexes $\text{Zn}_{Cu}+\text{Cu}_{Zn}$ and $\text{V}_{Cu}+\text{Zn}_{Cu}$ influence the CZTSe band gap in an opposite way, the former decreases $E_g$ whereas the latter increases it, which is beneficial for solar cell efficiency [5,36]. Recent nuclear magnetic resonance and Raman spectroscopy report suggests that in copper poor and zinc rich material $\text{V}_{Cu}+\text{Zn}_{Cu}$ can restrain the Cu/Zn disorder [37]. The proximity of the band gap of 1.00 eV at room temperature to that in excitonic grade material with elemental composition close to ideal stoichiometry [6] showing no band tail effects in the PL spectra can be taken as an indication of a low degree of the Cu/Zn disorder. The presence of the band-to-band transition in the PL spectra from cryogenic to room temperatures and the high conversion efficiency (8.1%) of the solar cell made of the film, simultaneously deposited on Mo/glass substrate with that examined in this study, can also be an indication of the low degree of the Cu/Zn disorder.

![Figure 9](image9.png)

**Figure 9.** Arrhenius plot of the temperature quenching of the BT band integrated intensity (○- experimental data, red line - fit using Eq.1).

### 4. Conclusions

CZTSe thin films with copper deficiency and zinc excess have been fabricated by the group at Northumbria University by the selenisation of metallic precursors magnetron deposited on Mo/glass and bare glass substrates. The films on glass were examined by transmission and reflection techniques at room temperature and PL spectroscopy at temperatures from 6 to 300 K whereas films on Mo/glass were used to produce a solar cell with efficiency of 8.1%. Detailed temperature and excitation intensity analysis of the PL spectra allows identification of the main recombination mechanisms as band-to-tail and band-to-band transitions. The latter transition was observed in the spectra from 6 to 300 K.

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